Unit: mm

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type ($L^2-\pi$ -MOSV)

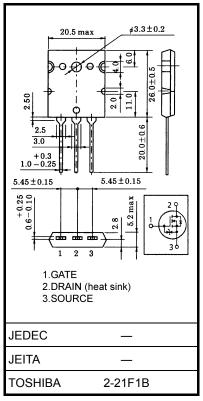
2SK2267

Chopper Regulator, DC–DC Converter and Motor Drive Applications

- 4-V gate drive
- Low drain-source ON resistance $: R_{DS} (ON) = 8 m\Omega (typ.)$
- High forward transfer admittance $|Y_{fs}| = 60 \text{ S (typ.)}$
- Low leakage current $: I_{DSS} = 100 \ \mu A \ (max) \ (V_{DS} = 60 \ V)$
- Enhancement mode : $V_{th} = 0.8 \sim 2.0 \text{ V} (V_{DS} = 10 \text{ V}, \text{ I}_D = 1 \text{ mA})$

Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V _{DSS}	60	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V _{DGR}	60	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	۱ _D	60	А	
	Pulse (Note 1)	I _{DP}	240	А	
Drain power dissipatio	n (Tc = 25°C)	PD	150	W	
Single pulse avalanche energy (Note 2)		E _{AS}	1054	mJ	
Avalanche current		I _{AR}	60	А	
Repetitive avalanche energy (Note 3)		E _{AR}	15	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	



Weight: 9.75 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	0.833	°C / W
Thermal resistance, channel to ambient	R _{th (ch−a)}	35.7	°C / W

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: V_{DD} = 25 V, T_{ch} = 25°C (initial), L = 398 µH, R_G = 25 Ω , I_{AR} = 60 A

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Please handle with caution.

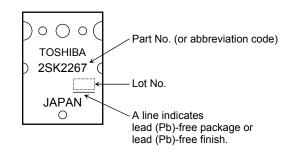
Electrical Characteristics (Ta = 25°C)

Charao	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit	
Gate leakage cu	ırrent	I _{GSS}	V_{GS} = ±16 V, V_{DS} = 0 V	_		±10	μA	
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 60 V, V _{GS} = 0 V	_		100	μA	
Drain-source br	eakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	60	_	_	V	
Gate threshold v	voltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	0.8	_	2.0	V	
Drain-source ON resistance		R _{DS (ON)}	V _{GS} = 4 V, I _D = 30 A		12	15	- mΩ	
			V _{GS} = 10 V, I _D = 30 A		8	11		
Forward transfe	r admittance	Y _{fs}	V _{DS} = 10 V, I _D = 30 A	40	60	_	S	
Input capacitant	xe	C _{iss}			5400	_		
Reverse transfer capacitance		C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		920	_	pF	
Output capacitance		C _{oss}			2600	_		
Switching time	Rise time	tr	$V_{GS} \stackrel{10V}{_{0V}} \int $	_	30	_		
	Turn-on time	t _{on}		_	60	_	20	
	Fall time	t _f		_	65	_	- ns	
	Turn–off time	t _{off}	$V_{DD} \Rightarrow 30V$ Duty $\leq 1\%$, t _w = 10 μ s	_	220	_		
Total gate charge (Gate–source plus gate–drain)		Qg		_	170	_		
Gate-source charge		Q _{gs}	V _{DD} ≈ 48 V, V _{GS} = 10 V, I _D = 60 A		110	—	nC	
Gate-drain ("miller") charge		Q _{gd}			60	—		

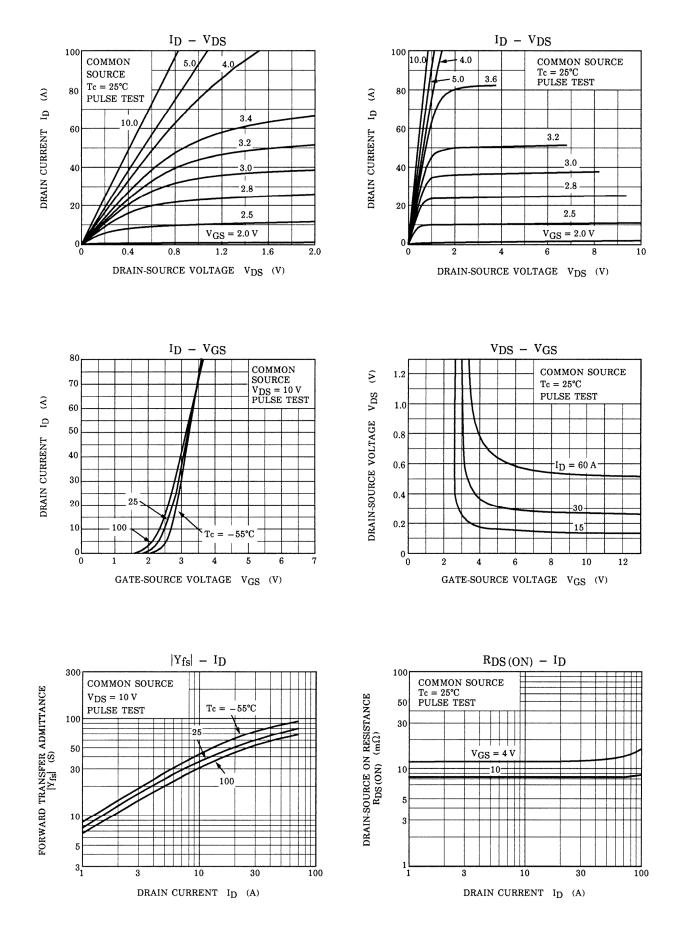
Source–Drain Ratings and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	60	А
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	240	А
Forward voltage (diode)	V _{DSF}	I _{DR} = 60 A, V _{GS} = 0 V	_	_	-1.7	V
Reverse recovery time	t _{rr}	I _{DR} = 60 A, V _{GS} = 0 V		150		ns
Reverse recovered charge	Q _{rr}	dI _{DR} / dt = 50 A / μs	_	0.3	_	μC

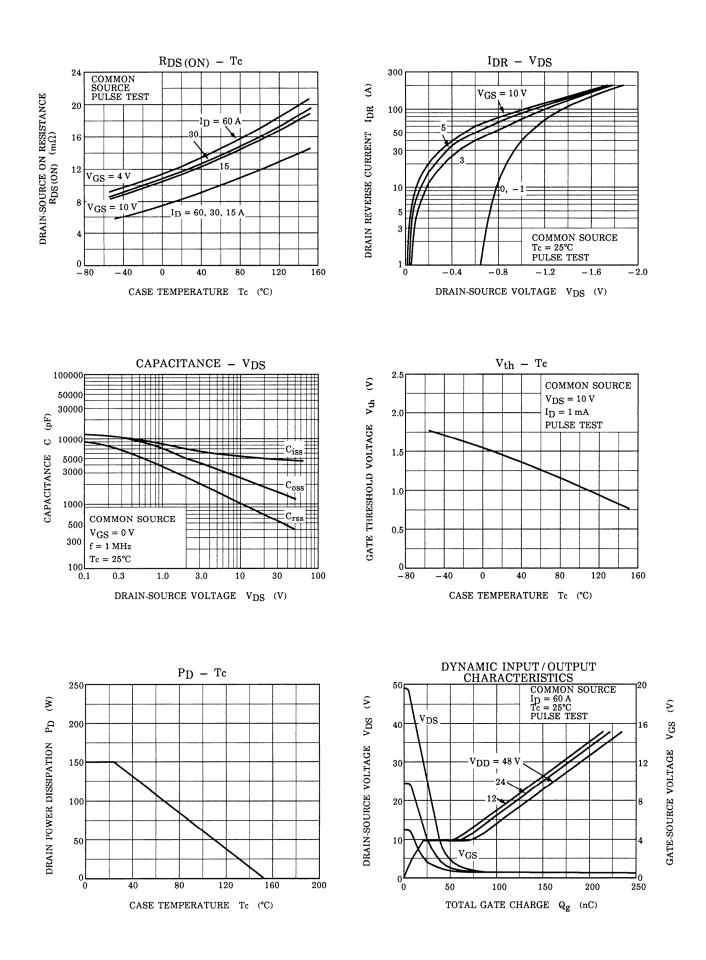
Marking

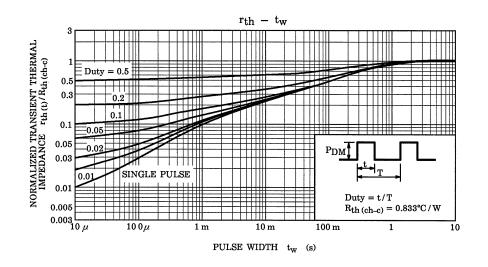


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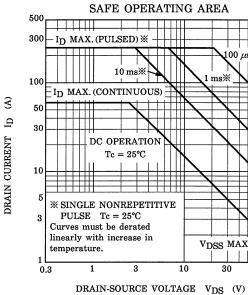


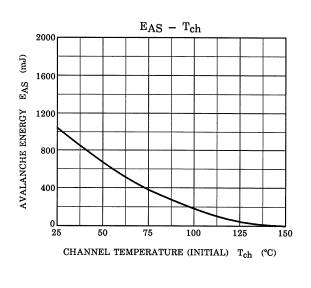


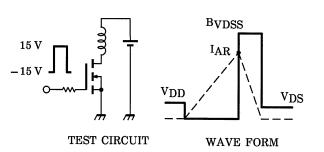
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30

100







 $R_G = 25 \ \Omega$ $EAS = \frac{1}{2} \cdot L \cdot I^2 \cdot \left(\frac{BVDSS}{BVDSS - VDD}\right)$ V_{DD} = 25 V, L = 398 μH

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